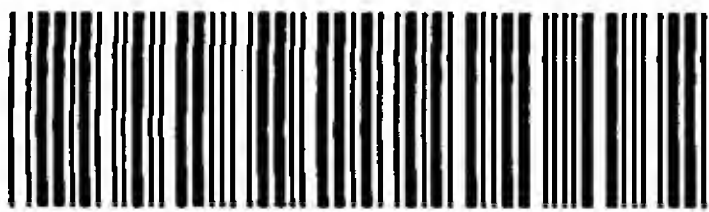


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/708,536	ZHOU ET AL.	
	Examiner	Art Unit	
	Erin D. Chiem	2883	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
text search		edc
(multi multiple plurality) near2 (film layer) same grin	6/11/2007	EDC